







**CSD18502KCS** SLPS367C - OCTOBER 2011 - REVISED MARCH 2024

# CSD18502KCS 40V N-Channel NexFET™ Power MOSFET

#### 1 Features

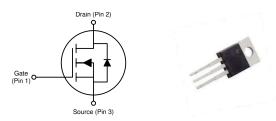
- Ultra-low  $\mathbf{Q}_{g}$  and  $\mathbf{Q}_{gd}$  Low thermal resistance
- Avalanche rated
- Logic level
- Pb free terminal plating
- RoHS compliant
- Halogen free
- TO-220 plastic package

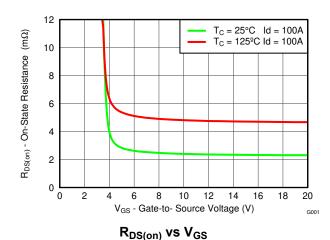
# 2 Applications

- DC-DC conversion
- Secondary side synchronous rectifier
- Motor control

## 3 Description

This 40V, 2.4mΩ, TO-220 NexFET™ power MOSFET is designed to minimize losses in power conversion applications.





**Product Summary** 

T <sub>A</sub> = 25°	С	TYPICAL VA	UNIT	
V <sub>DS</sub>	Drain-to-Source Voltage	40		V
Qg	Gate Charge Total (10V)	52		nC
Q <sub>gd</sub>	Gate Charge Gate-to-Drain	8.4		nC
	Drain-to-Source On Resistance	V <sub>GS</sub> = 4.5V 3.3		mΩ
R <sub>DS(on)</sub>	Drain-to-Source On Resistance	V <sub>GS</sub> = 10V 2.4		mΩ
V <sub>GS(th)</sub>	Threshold Voltage	1.8		V

# Ordering Information<sup>(1)</sup>

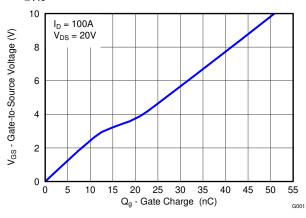
Device	Package	Media	Qty	Ship	
CSD18502KCS	TO-220 Plastic Package	Tube	50	Tube	

For all available packages, see the orderable addendum at the end of the data sheet.

#### **Absolute Maximum Ratings**

$T_A = 2$	25°C	VALUE	UNIT		
V <sub>DS</sub>	Drain-to-Source Voltage	40	V		
$V_{GS}$	Gate-to-Source Voltage	±20			
	Continuous Drain Current (Package limited)	100			
I <sub>D</sub>	Continuous Drain Current (Silicon limited), T <sub>C</sub> = 25°C	212	Α		
	Continuous Drain Current (Silicon limited), T <sub>C</sub> = 100°C	150			
I <sub>DM</sub>	Pulsed Drain Current (1)	400	Α		
P <sub>D</sub>	Power Dissipation	259	W		
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	-55 to 175	°C		
E <sub>AS</sub>	Avalanche Energy, single pulse $I_D$ = 81A, L = 0.1mH, $R_G$ = 25 $\Omega$	330	mJ		

(1) Max R<sub>θJC</sub> = 0.6°C/W, pulse duration ≤100μs, duty cycle ≤1%



**Gate Charge** 



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# 4 Specifications

## **4.1 Electrical Characteristics**

(T<sub>A</sub> = 25°C unless otherwise stated)

PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
CHARACTERISTICS		-		
Drain-to-Source Voltage	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA	40		V
Drain-to-Source Leakage Current	V <sub>GS</sub> = 0V, V <sub>DS</sub> = 32V		1	μA
Gate-to-Source Leakage Current	V <sub>DS</sub> = 0V, V <sub>GS</sub> = 20V		100	nA
Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.5 1.8	2.1	V
Duein to Course On Bosistanos	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 100A	3.3	4.3	mΩ
Drain-to-Source On Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 100A	2.4	2.9	mΩ
Transconductance	V <sub>DS</sub> = 20V, I <sub>D</sub> = 100A	138		S
IC CHARACTERISTICS	·			
Input Capacitance		3900	4680	pF
Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V, f = 1MHz$	900	1080	pF
Reverse Transfer Capacitance		21	26	pF
Series Gate Resistance		1.2	2.4	Ω
Gate Charge Total (4.5 V)		25	30	nC
Gate Charge Total (10 V)		52	62	nC
Gate Charge Gate-to-Drain	$V_{DS} = 20V, I_D = 100A$	8.4		nC
Gate Charge Gate-to-Source		10.3		nC
Gate Charge at V <sub>th</sub>		7.5		nC
Output Charge	V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V	52		nC
Turn On Delay Time		11		ns
Rise Time	V <sub>DS</sub> = 20V, V <sub>GS</sub> = 10V,	7.3		ns
Turn Off Delay Time	$I_{DS} = 100A, R_G = 0\Omega$	33		ns
Fall Time		9.3		ns
CHARACTERISTICS	·			
Diode Forward Voltage	I <sub>SD</sub> = 100A, V <sub>GS</sub> = 0V	0.8	1	V
Reverse Recovery Charge	V <sub>DS</sub> = 20V, I <sub>F</sub> = 100A,	105		nC
Reverse Recovery Time	di/dt = 300A/μs	48		ns
	Drain-to-Source Voltage Drain-to-Source Leakage Current Gate-to-Source Leakage Current Gate-to-Source Threshold Voltage Drain-to-Source On Resistance Transconductance C CHARACTERISTICS Input Capacitance Output Capacitance Reverse Transfer Capacitance Series Gate Resistance Gate Charge Total (4.5 V) Gate Charge Total (10 V) Gate Charge Gate-to-Drain Gate Charge Gate-to-Source Gate Charge at V <sub>th</sub> Output Charge Turn On Delay Time Rise Time Turn Off Delay Time Fall Time CHARACTERISTICS Diode Forward Voltage Reverse Recovery Charge	CHARACTERISTICS         Drain-to-Source Voltage $V_{GS} = 0V$ , $I_{D} = 250\mu$ A         Drain-to-Source Leakage Current $V_{DS} = 0V$ , $V_{DS} = 32V$ Gate-to-Source Threshold Voltage $V_{DS} = 0V$ , $V_{CS}$ , $I_{D} = 250\mu$ A         Drain-to-Source On Resistance $V_{DS} = V_{CS}$ , $I_{D} = 250\mu$ A         Transconductance $V_{CS} = 10V$ , $I_{D} = 100A$ C CHARACTERISTICS       Input Capacitance         Input Capacitance $V_{CS} = 0V$ , $V_{DS} = 20V$ , $f = 1$ MHz         Reverse Transfer Capacitance $V_{CS} = 0V$ , $V_{DS} = 20V$ , $f = 1$ MHz         Reverse Gate Resistance $V_{CS} = 0V$ , $V_{DS} = 20V$ , $V_{CS} = 10V$ , $V_{CS} = $	CHARACTERISTICS           Drain-to-Source Voltage $V_{GS} = 0$ V, $I_D = 250 \mu A$ 40           Drain-to-Source Leakage Current $V_{GS} = 0$ V, $V_{DS} = 32$ V           Gate-to-Source Threshold Voltage $V_{DS} = 0$ V, $V_{GS} = 20$ V           Gate-to-Source Threshold Voltage $V_{DS} = V_{GS}$ , $I_D = 250 \mu A$ 1.5         1.8           Drain-to-Source On Resistance $V_{GS} = 4.5$ V, $I_D = 100$ A         3.3           Transconductance $V_{DS} = 20$ V, $I_D = 100$ A         2.4           Transconductance $V_{DS} = 20$ V, $I_D = 100$ A         3.3           CCHARACTERISTICS           Input Capacitance $V_{DS} = 20$ V, $V_D = 20$	CHARACTERISTICS           Drain-to-Source Voltage         V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA         40           Drain-to-Source Leakage Current         V <sub>GS</sub> = 0V, V <sub>DS</sub> = 32V         1           Gate-to-Source Leakage Current         V <sub>DS</sub> = 0V, V <sub>DS</sub> = 20V         100           Gate-to-Source Threshold Voltage         V <sub>DS</sub> = 20V, V <sub>DS</sub> = 250µA         1.5         1.8         2.1           Drain-to-Source On Resistance         V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 100A         2.4         2.9           Transconductance         V <sub>DS</sub> = 20V, I <sub>D</sub> = 100A         2.4         2.9           Transconductance         V <sub>DS</sub> = 20V, I <sub>D</sub> = 100A         330         4680           CC CHARACTERISTICS         Input Capacitance         3900         4680           Input Capacitance         V <sub>GS</sub> = 0V, V <sub>DS</sub> = 20V, J = 1MHz         900         1080           Reverse Transfer Capacitance         3900         4680         4680           Reverse Gate Resistance         1.2         2.4         2.9           Gate Charge Total (4.5 V)         25         30           Gate Charge Total (10 V)         52         62           Gate Charge Gate-to-Drain         V <sub>DS</sub> = 20V, I <sub>D</sub> = 100A         8.4           Gate Charge at V <sub>Ih</sub> 7.5

# 4.2 Thermal Information

(T<sub>A</sub> = 25°C unless otherwise stated)

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance			0.6	°C/W
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance			62	C/VV

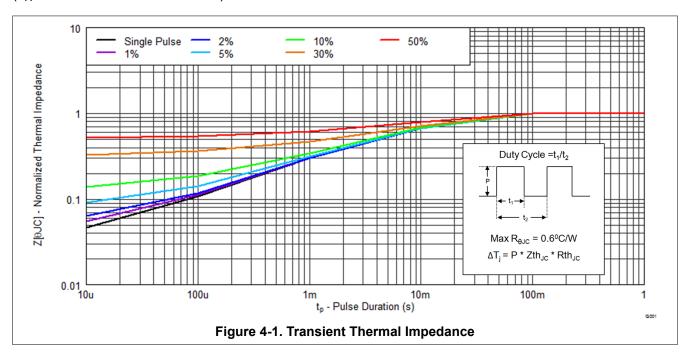
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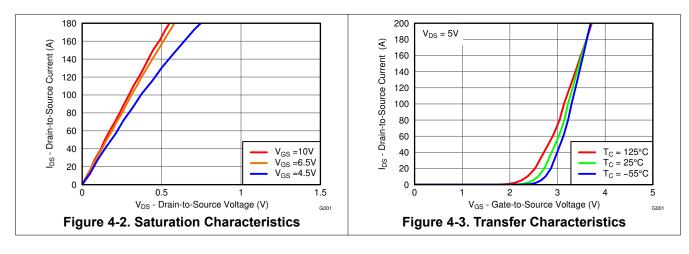
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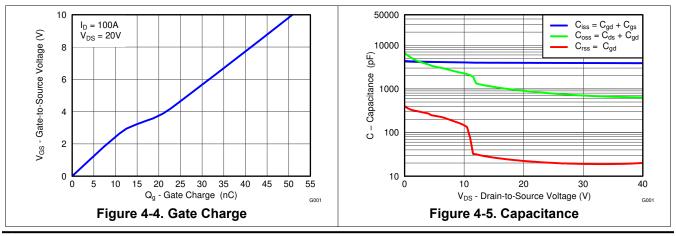


## 4.3 Typical MOSFET Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 







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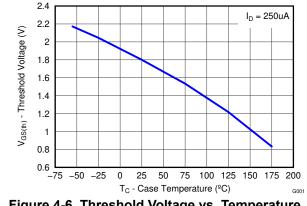


Figure 4-6. Threshold Voltage vs. Temperature

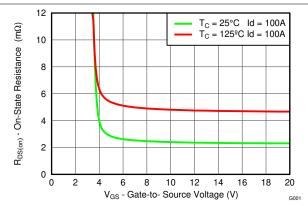


Figure 4-7. On-State Resistance vs. Gate-to-Source Voltage

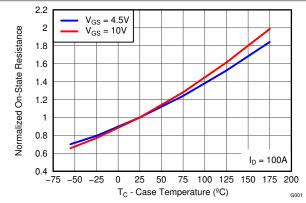


Figure 4-8. Normalized On-State Resistance vs. **Temperature** 

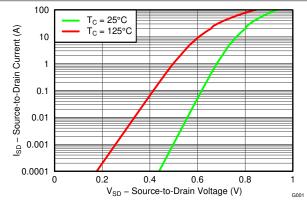


Figure 4-9. Typical Diode Forward Voltage

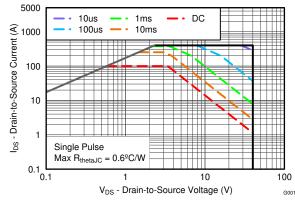


Figure 4-10. Maximum Safe Operating Area

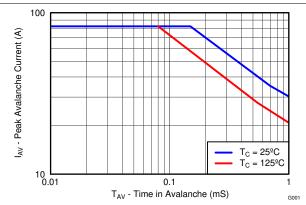
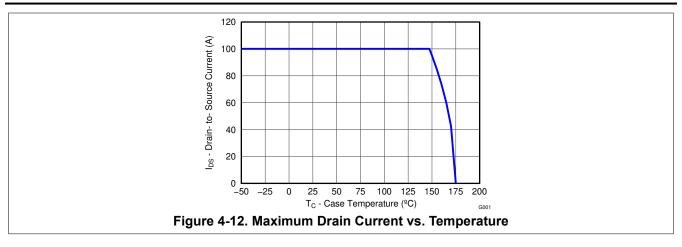


Figure 4-11. Single Pulse Unclamped Inductive **Switching** 







## **5 Device and Documentation Support**

### 5.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### **5.2 Support Resources**

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 5.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.



# 6 Revision History

N	OTE: Page numbers for previous revisions may differ from page numbers in the current version.	
С	hanges from Revision B (July 2014) to Revision C (March 2024)	Page
•	Updated the numbering format for tables, figures, and cross-references throughout the document	1
С	hanges from Revision A (October 2012) to Revision B (July 2014)	Page
•	Increased the T <sub>C</sub> = 25° continuous drain current to 212A	1
•	Increased the T <sub>C</sub> = 125° continuous drain current to 150A	1
•	Increased the pulsed drain current to 400A	1
•	Increased the max power dissipation to 259W	1
•	Increased the max operating junction and storage temperature to 175°	1
•	Updated the pulsed current conditions	
•	Updated Figure 4-1 from a normalized R <sub>θJA</sub> to an R <sub>θJC</sub> curve	
•	Updated Figure 4-6 to extend to 175°C	4
•	Updated Figure 4-8 to extend to 175°C	4
•	Updated the SOA in Figure 4-10	4
•	Updated Figure 4-12 to extend to 175°C	4
С	hanges from Revision * (August 2012) to Revision A (October 2012)	Page
•	Changed the Transconductance TYP value From: 149S To: 138S	3
•	Changed R <sub>0JA</sub> From: 65°C/W To: 62°C/W	3



# 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
CSD18502KCS	Active	Production	TO-220 (KCS)   3	50   TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD18502KCS
CSD18502KCS.B	Active	Production	TO-220 (KCS)   3	50   TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD18502KCS

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

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#### **TUBE**



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CSD18502KCS	KCS	TO-220	3	50	532	34.1	700	9.6
CSD18502KCS.B	KCS	TO-220	3	50	532	34.1	700	9.6



TO-220



#### NOTES:

- 1. Dimensions are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. Reference JEDEC registration TO-220.



TO-220



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